

Notice of References Cited

Application/Control No.

10/521,520

Applicant(s)/Patent Under
Reexamination
SNYDER ET AL.

Examiner

STEVEN KELLEY

Art Unit

2617

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,366,530	04-2008	McCann et al.	455/466
*	B	US-7,164,488	01-2007	Henry, Matthew K.	358/1.15
*	C	US-7,116,994	10-2006	Hatch, Richard	455/466
*	D	US-7,079,524	07-2006	Bantukul et al.	370/349
*	E	US-7,068,772	06-2006	Widger et al.	379/222
*	F	US-7,010,303	03-2006	Lewis et al.	455/445
*	G	US-7,003,307	02-2006	Kupsh et al.	455/466
*	H	US-6,678,265	01-2004	Kung et al.	370/352
*	I	US-6,611,516	08-2003	Pirkola et al.	370/352
*	J	US-6,275,490	08-2001	Mattaway et al.	370/352
*	K	US-6,011,834	01-2000	Jeong, Kwang-Jae	379/88.26
*	L	US-2004/0142707	07-2004	Midkiff et al.	455/466
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	X					

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